

# SKM600GB12M7



SEMITRANS® 3

## IGBT M7 Modules

### SKM600GB12M7

#### Features\*

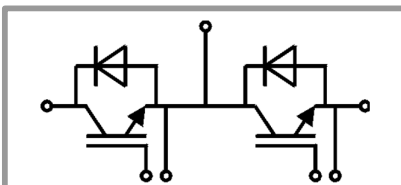
- $V_{CE(sat)}$  with positive temperature coefficient
- High overload capability
- Low loss, high density IGBTs
- Fast & soft switching inverse CAL diodes
- Large clearance (10 mm) and creepage distance (20 mm)
- Insulated copper baseplate using DCB Technology (Direct Copper Bonding)
- With integrated gate resistor

#### Typical Applications

- AC inverter drives
- UPS
- Renewable energy systems

#### Remarks

- Max case temperature limited to  $T_c = T_s = 125^\circ\text{C}$
- Product reliability results are valid for  $T_j = 150^\circ\text{C}$  (recommended  $T_{j,op} = -40 \dots +150^\circ\text{C}$ )
- For storage and case temperature with TIM see document: "Technical Explanations Thermal Interface materials"



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Absolute Maximum Ratings				
Symbol	Conditions	Values	Unit	
<b>IGBT</b>				
$V_{CES}$	$T_j = 25^\circ\text{C}$	1200	V	
$I_C$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	779	A
		$T_c = 80^\circ\text{C}$	591	A
$I_{Cnom}$		600	A	
$I_{CRM}$		1200	A	
$V_{GES}$		-20 ... 20	V	
$t_{psc}$	$V_{CC} = 800\text{ V}$ $V_{GE} \leq 15\text{ V}$ $V_{CES} \leq 1200\text{ V}$	$T_j = 150^\circ\text{C}$	8	$\mu\text{s}$
$T_j$			-40 ... 175	$^\circ\text{C}$
<b>Inverse diode</b>				
$V_{RRM}$	$T_j = 25^\circ\text{C}$	1200	V	
$I_F$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	688	A
		$T_c = 80^\circ\text{C}$	513	A
$I_{FRM}$		1200	A	
$I_{FSM}$	$t_p = 10\text{ ms}$ , sin 180°, $T_j = 25^\circ\text{C}$	3240	A	
$T_j$			-40 ... 175	$^\circ\text{C}$
<b>Module</b>				
$I_{t(RMS)}$		500	A	
$T_{stg}$	module without TIM	-40 ... 125	$^\circ\text{C}$	
$V_{isol}$	AC sinus 50 Hz, $t = 1\text{ min}$	4000	V	

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
<b>IGBT</b>					
$V_{CE(sat)}$	$I_C = 600\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.55	1.88	V
		$T_j = 150^\circ\text{C}$	1.80		V
$V_{CE0}$	chipelevel	$T_j = 25^\circ\text{C}$	0.87	0.95	V
		$T_j = 150^\circ\text{C}$	0.76		V
$r_{CE}$	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.13	1.55	m $\Omega$
		$T_j = 150^\circ\text{C}$	1.73		m $\Omega$
$V_{GE(th)}$	$V_{CE} = 10\text{ V}$ , $I_C = 60\text{ mA}$	5.4	6	6.6	V
$I_{CES}$	$V_{GE} = 0\text{ V}$ , $V_{CE} = 1200\text{ V}$ , $T_j = 25^\circ\text{C}$			5	mA
$C_{ies}$	$V_{CE} = 10\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	120		nF
$C_{oes}$		$f = 1\text{ MHz}$	3.66		nF
$C_{res}$		$f = 1\text{ MHz}$	1.28		nF
$Q_G$	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		5360		nC
$R_{Gint}$	$T_j = 25^\circ\text{C}$		0.8		$\Omega$
$t_{d(on)}$	$V_{CC} = 600\text{ V}$ $I_C = 600\text{ A}$ $V_{GE} = +15/-15\text{ V}$	$T_j = 150^\circ\text{C}$	260		ns
$t_r$		$T_j = 150^\circ\text{C}$	85		ns
$E_{on}$	$R_{Gon} = 1.2\ \Omega$	$T_j = 150^\circ\text{C}$	57		mJ
$t_{d(off)}$	$R_{Goff} = 1\ \Omega$	$T_j = 150^\circ\text{C}$	436		ns
$t_f$	$di/dt_{on} = 8000\text{ A}/\mu\text{s}$ $di/dt_{off} = 5240\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$	95		ns
$E_{off}$	$dv/dt = 5960\text{ V}/\mu\text{s}$	$T_j = 150^\circ\text{C}$	68		mJ
$R_{th(j-c)}$	per IGBT			0.066	K/W
$R_{th(c-s)}$	per IGBT, P12 (reference)		0.037		K/W
$R_{th(c-s)}$	per IGBT, HP-PCM		0.02		K/W

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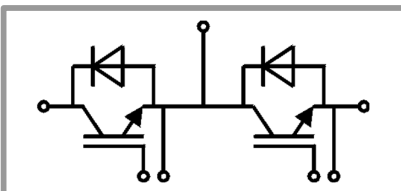
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Characteristics						
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<b>Inverse diode</b>						
$V_F = V_{EC}$	$I_F = 600\text{ A}$ $V_{GE} = 0\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$		2.14	2.46	V
		$T_j = 150^\circ\text{C}$		2.07		V
$V_{F0}$	chipelevel	$T_j = 25^\circ\text{C}$		1.30	1.50	V
		$T_j = 150^\circ\text{C}$		0.90		V
$r_F$	chipelevel	$T_j = 25^\circ\text{C}$		1.40	1.60	m $\Omega$
		$T_j = 150^\circ\text{C}$		1.95		m $\Omega$
$I_{RRM}$	$V_{CC} = 600\text{ V}$	$T_j = 150^\circ\text{C}$		555		A
$Q_{rr}$	$I_F = 600\text{ A}$ $V_{GE} = -15\text{ V}$	$T_j = 150^\circ\text{C}$		92		$\mu\text{C}$
$E_{rr}$	$di/dt_{off} = 8000\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		43		mJ
$R_{th(j-c)}$	per diode				0.09	K/W
$R_{th(c-s)}$	per diode, P12 (reference)			0.038		K/W
$R_{th(c-s)}$	per diode, HP-PCM			0.021		K/W
<b>Module</b>						
$L_{CE}$				15		nH
$R_{CC+EE}$	measured per switch	$T_j = 25^\circ\text{C}$		0.55		m $\Omega$
		$T_j = 150^\circ\text{C}$		0.85		m $\Omega$
$R_{th(c-s)1}$	calculated without thermal coupling, P12 (reference)			0.0093		K/W
$R_{th(c-s)2}$	including thermal coupling, $T_s$ underneath module, P12 (reference)			0.015		K/W
$R_{th(c-s)2}$	including thermal coupling, $T_s$ underneath module, HP-PCM			0.0078		K/W
$M_s$	to heat sink M6		3		5	Nm
$M_t$	to terminal M5		2.5		5	Nm
				-		Nm
w					325	g

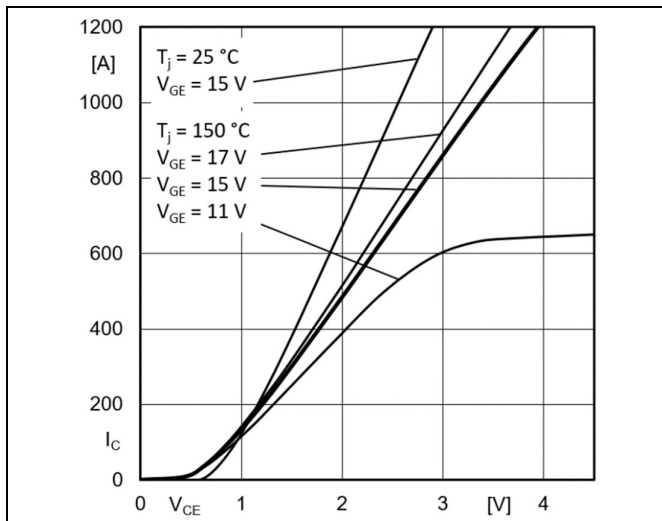


Fig. 1: Typ. output characteristic, inclusive  $R_{CC+EE'}$

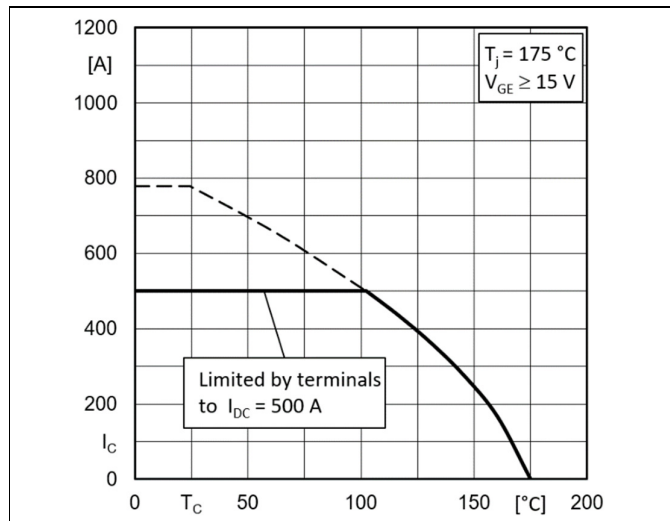


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

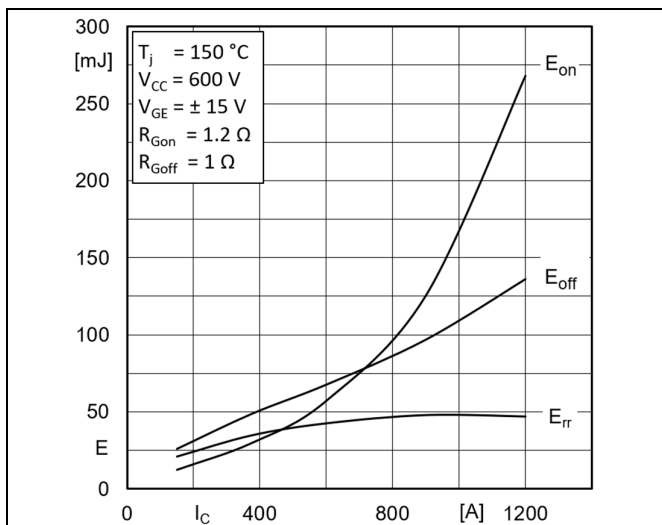


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

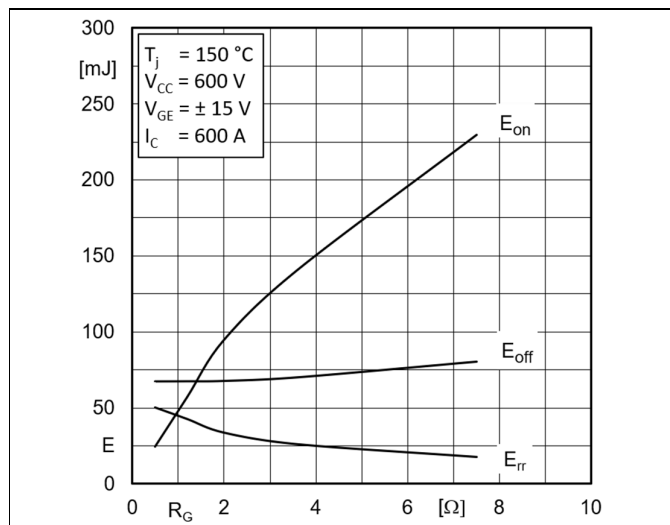


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

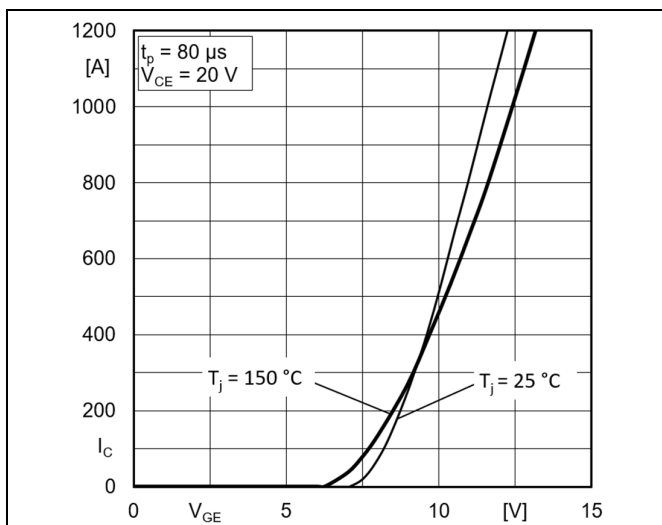


Fig. 5: Typ. transfer characteristic

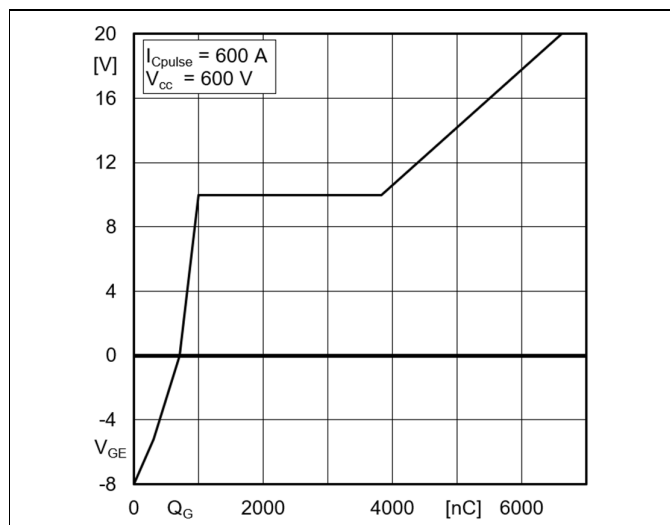


Fig. 6: Typ. gate charge characteristic

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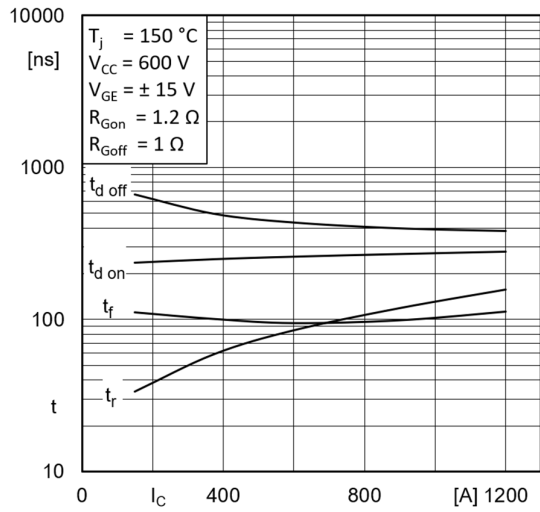


Fig. 7: Typ. switching times vs.  $I_c$

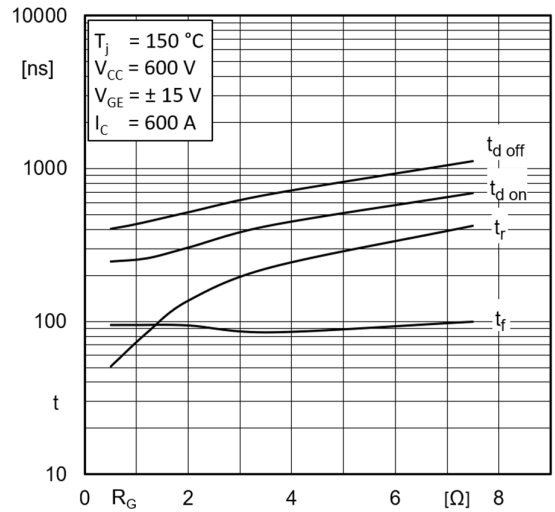


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

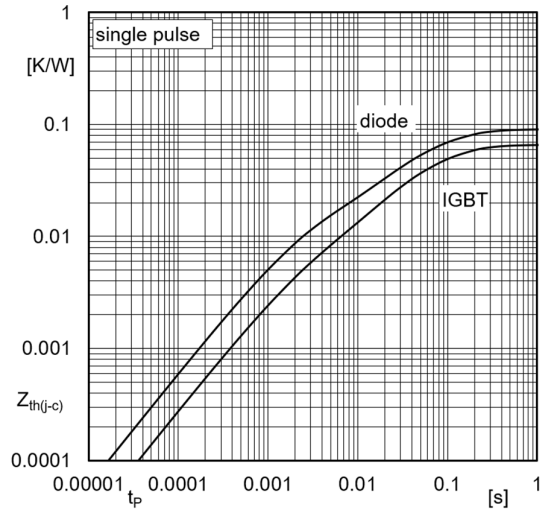


Fig. 9: Transient thermal impedance

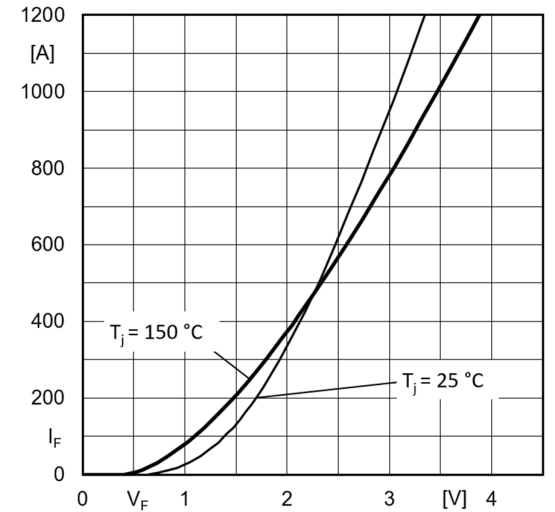


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC+EE}$

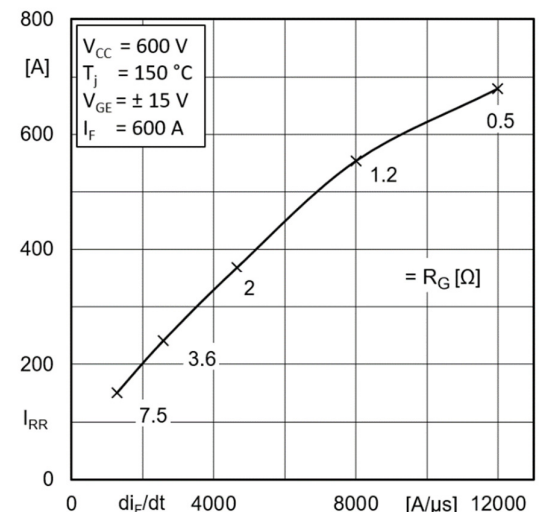


Fig. 11: CAL diode peak reverse recovery current

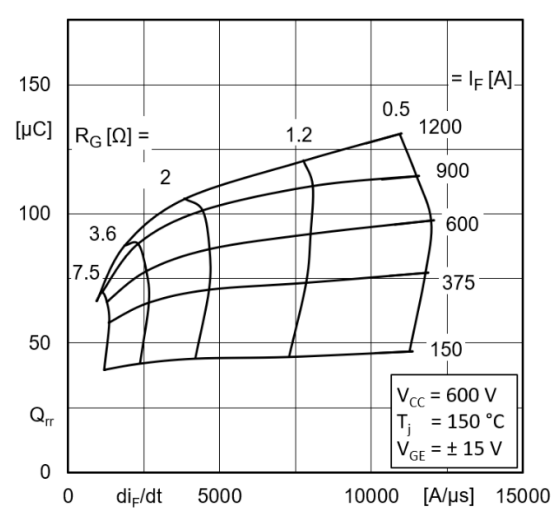
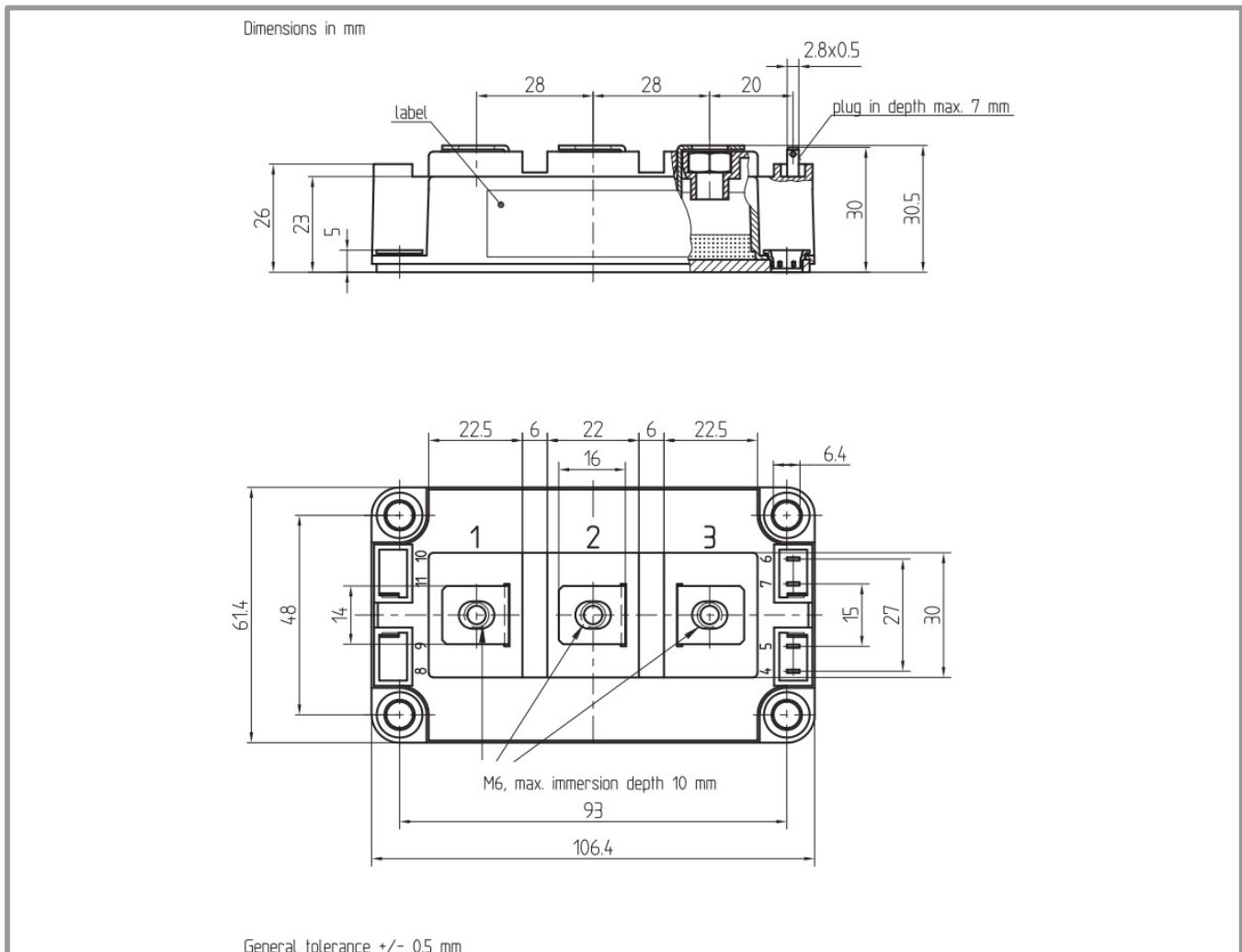
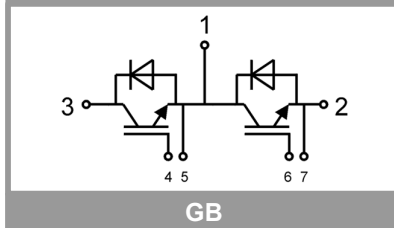


Fig. 12: Typ. CAL diode peak reverse recovery charge



## Pinout and Dimensions



This is an electrostatic discharge sensitive device (ESDS) according to international standard IEC 61340.

### \*IMPORTANT INFORMATION AND WARNINGS

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